

Applicant Initiated Interview Request Form

Application No.: 10/575,531 First Named Applicant: Hiroyuki TSUKASHIMA
 Examiner: A. WILLIAMS Art Unit: 2838 Status of Application: Final Rejection

Tentative Participants:

(1) Smith Sirisakorn (2) Eric Morehouse
 (3) _____ (4) _____

Proposed Date of Interview: June 22, 2009 Proposed Time: 10:00 AM

Type of Interview Requested:

(1) ☐ Telephonic (2) ☒ Personal (3) ☐ Video Conference

Exhibit To Be Shown or Demonstrated: ☐ YES ☒ NO

If yes, provide brief description: _____

Issues To Be Discussed

| Issues (Rej., Obj., etc) | Claims/ Fig. #s | Applied Reference(s) | Discussed | Agreed | Not Agreed |
|-----------------------------|--------------------------|---|--------------------------|--------------------------|--------------------------|
| (1) §103(a) Rej. | Claims 1, 5 Figs. 5-9 | U.S. Patent Application Publication No. 2002/0050752 (Katsuzawa), U.S. Patent Application Publication No. 2004/0201296 (Hama) | <input type="checkbox"/> | <input type="checkbox"/> | <input type="checkbox"/> |

☐ Continuation Sheet Attached

Brief Description of Arguments to be Presented:

Hama and Katsuzawa fail to at least teach "the second contact is capable of absorbing a component tolerance at least due to its elastically deformable properties," as recited in independent claim 1; and "the second contact is capable of absorbing a component tolerance at least due to having a through-hole that has a length sufficiently greater than the diameter of the fixing member to allow for translational movement within the through-hole," as recited in independent claim 5.

An interview was conducted on the above-identified application on _____

NOTE:

This form should be completed by applicant and submitted to the examiner in advance of the interview (see MPEP § 713.01).

This application will not be delayed from issue because of applicant's failure to submit a written record of this interview. Therefore, applicant is advised to file a statement of substance of this interview (37 CFR 1.133(b) as soon as possible.

 (Applicant/Applicant's Representative Signature)

 (Examiner/SPE Signature)